

Differential PECL-compatible outputs 700 ps propagation delay input to output

75 ps propagation delay dispersion

Robust input protection

Differential latch control Internal latch pull-up resistors

700 ps minimum pulse width

Programmable hysteresis

Automatic test equipment

High speed instrumentation

Scope and logic analyzer front ends

Disk drive read channel detection Hand-held test instruments Zero-crossing detectors

Line receivers and signal restoration

APPLICATIONS

Window comparators

Peak detection High speed triggers Patient diagnostics

Clock drivers

High speed line receivers Threshold detection

Input common-mode range: -2.0 V to +3.0 V

Power supply rejection greater than 85 dB

Typical output rise/fall time of 500 ps ESD protection > 4 kV HBM, >200 V MM

1.5 GHz equivalent input rise time bandwidth

Dual High Speed PECL Comparators

Data Sheet

FEATURES

ADCMP561/ADCMP562

FUNCTIONAL BLOCK DIAGRAM

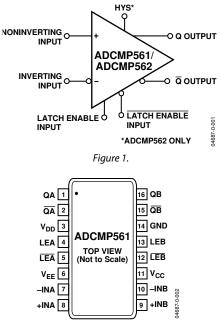


Figure 2. ADCMP561 16-Lead QSOP Pin Configuration

	+INA 9 12 +INB	-INA 8 13 -INB	V _{EE} 7 14 V _{CC}		-INA 8	• ADCMP562 TOP VIEW (Not to Scale)	13 –INB	200-0-2897-0-00-6
		V _{EE} 7 14 V _{CC}		QA 2 QA 3 V _{DD} 4 LEA TOP VIEW	LEA 6	. ,	15 LEB	
V _{EE} 7 –INA 8 III –INB	V _{EE} 7 14 V _{CC}		LEA 6	QA 2 QA 3 V _{DD} 4 ADCMP562 17 GND	LEA 5		16 LEB	
LEA 5 (Not to Scale) 16 LEB LEA 6 15 LEB VEE 7 14 Vcc -INA 8 13 -INB	LEA 5 (Not to Scale) 16 LEB LEA 6 15 LEB VEE 7 14 Vcc	LEA 6 (Not to Scale) 16 LEB 15 LEB	LEA 5 (Not to Scale) 16 LEB	QA 2 19 QB	V _{DD} 4		17 GND	
LEA 5 TOP VIEW (Not to Scale) 16 LEB LEA 6 15 LEB VEE 7 14 Vcc -INA 8 13 -INB	LEA 5 LEA 6 VEE 7 UDP VIEW (Not to Scale) 16 LEB 15 LEB 14 V _{CC}	LEA 5 LEA 6 LEA 6	LEA 5 (Not to Scale) 16 LEB		QA 3		18 QB	
V _{DD} 4 ADCMP562 17 GND LEA 5 TOP VIEW (Not to Scale) 16 LEB LEA 6 15 LEB V _{EE} 7 14 V _{CC} -INA 6 III - INB	VDD 4 ADCMP562 17 GND LEA 5 TOP VIEW (Not to Scale) 16 LEB LEA 6 11 GND 16 LEB VEE 7 14 Vcc 14 Vcc	V _{DD} 4 ADCMP562 17 GND LEA 5 (Not to Scale) 16 LEB LEA 6	V _{DD} 4 ADCMP562 17 GND LEA 5 TOP VIEW (Not to Scale) 16 LEB		QA 2		19 QB	
QA 3 V _{DD} 4 LEA 5 LEA 6 V _{EE} 7 -INA 6 MADE 118 QB 117 GN 16 LEA 6 V _{EE} 7 -INA 0 MA 0	QA 3 V _{DD} 4 LEA 5 LEA 6 V _{EE} 7	QA 3 18 QB V _{DD} 4 ADCMP562 17 GND LEA 5 TOP VIEW (Not to Scale) 16 LEB LEA 6 15 LEB	QA 3 V _{DD} 4 TOP VIEW (Not to Scale) 16 LEB		V _{DD} 1	•	20 V _{DD}	

Figure 3. ADCMP562 20-Lead QSOP Pin Configuration

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GENERAL DESCRIPTION

The ADCMP561/ADCMP562 are high speed comparators fabricated on Analog Devices, Inc., proprietary XFCB process. The devices feature a 700 ps propagation delay with less than 75 ps overdrive dispersion. Dispersion, a measure of the difference in propagation delay under differing overdrive conditions, is a particularly important characteristic of comparators. A separate programmable hysteresis pin is available on the ADCMP562.

A differential input stage permits consistent propagation delay with a wide variety of signals in the common-mode range from -2.0 V

Rev. B

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to +3.0 V. Outputs are complementary digital signals that are fully compatible with PECL 10 K and 10 KH logic families. The outputs provide sufficient drive current to directly drive transmission lines terminated in 50 Ω to $V_{\rm DD}$ – 2 V. A latch input, which is included, permits tracking, track-and-hold, or sample-and-hold modes of operation. The latch input pins contain internal pull-ups that set the latch in tracking mode when left open.

The ADCMP561/ADCMP562 are specified over the industrial temperature range (-40°C to +85°C).

One Technology Way, P.O. Box 9106, Norwood, MA 02062-9106, U.S.A. Tel: 781.329.4700 ©2004–2017 Analog Devices, Inc. All rights reserved. Technical Support www.analog.com

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REVISION HISTORY

2/2017—Data Sheet Changed from Rev. A to Rev. B					
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Changes to Ordering Guide	. 14				
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SPECIFICATIONS

 V_{CC} = +5.0 V, V_{EE} = -5.2 V, V_{DD} = +3.3 V, T_A = -40°C to +85°C. Typical values are at T_A = +25°C, unless otherwise noted.

Table 1. Electrical Characteristics

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
DC INPUT CHARACTERISTICS						
Input Voltage Range			-2.0		3.0	V
Input Differential Voltage			-5		+5	V
Input Offset Voltage	Vos	$V_{CM} = 0 V$	-10.0	±2.0	+10.0	mV
Input Offset Voltage Channel Matching				±2.0		mV
Offset Voltage Tempco	∆Vos/d⊤			2.0		μV/°C
Input Bias Current	I _{IN}	-IN = -2 V, $+IN = +3 V$	-10.0	±3	+10.0	μA
Input Bias Current Tempco				0.5		nA/°C
Input Offset Current				±1.0		μA
Input Capacitance	CIN			0.75		рF
Input Resistance, Differential Mode				750		kΩ
Input Resistance, Common Mode				1800		kΩ
Active Gain	Av			63		dB
Common-Mode Rejection Ratio	CMRR	$V_{CM} = -2.0 V \text{ to } +3.0 V$		80		dB
Hysteresis		R _{HYS} = ∞		±1.0		mV
LATCH ENABLE CHARACTERISTICS						
Latch Enable Voltage Range			V _{DD} – 2.0		V _{DD}	v
Latch Enable Differential Voltage Range			0.4		2.0	v
Latch Enable Input High Current		@V _{DD}	-300		+300	μA
Latch Enable Input Low Current		@ V _{DD} -2.0 V	-300		+300	μA
LE Voltage, Open		Latch inputs not connected	V _{DD} – 0.2	V _{DD}	V _{DD} + 0.1	V
LE Voltage, Open		Latch inputs not connected	$V_{DD}/2 - 0.2$	$V_{DD}/2$	$V_{DD}/2 + 0.2$	v
Latch Setup Time	ts	$V_{OD} = 250 \text{ mV}$		250		ps
Latch Hold Time	t _H	$V_{OD} = 250 \text{ mV}$		250		ps
Latch-to-Output Delay	tploh, tplol	$V_{OD} = 250 \text{ mV}$		600		ps
Latch Minimum Pulse Width	tPLOH, CPLOE	$V_{OD} = 250 \text{ mV}$		500		ps
DC OUTPUT CHARACTERISTICS	UTL			500		P3
Output Voltage—High Level	V _{OH}	PECL 50 Ω to V _{DD} – 2.0 V	V _{DD} – 1.15		V _{DD} – 0.81	v
Output Voltage—Low Level	VOH VOL	PECL 50 Ω to $V_{DD} = 2.0 V$	$V_{DD} = 1.13$ $V_{DD} = 1.95$		VDD - 0.01 VDD - 1.54	v
Rise Time	t _R	10% to 90%	VUU - 1.95	550	VID - 1.34	-
Fall Time	t _F	10% to 90%		470		ps
AC PERFORMANCE	LF			470		ps
Propagation Delay	+	$V_{OD} = 1 V$		700		nc
Fiopagation Delay	t _{PD}	$V_{OD} = 1 V$ $V_{OD} = 20 \text{ mV}$		830		ps
Propagation Dolay Tampeo	∆+ /d	$V_{OD} = 20 \text{ mV}$ $V_{OD} = 1 \text{ V}$		0.25		ps
Propagation Delay Tempco Prop Delay Skew—Rising Transition to	$\Delta t_{PD} / d_T$			0.25		ps/°C
Falling Transition		$V_{OD} = 1 V$		50		ps
Within Device Propagation Delay Skew— Channel-to-Channel		$V_{OD} = 1 V$		50		ps
Overdrive Dispersion		$20 \text{ mV} \leq V_{\text{OD}} \leq 100 \text{ mV}$		75		ps
Overdrive Dispersion		$100 \text{ mV} \le V_{\text{OD}} \le 1.5 \text{ V}$		75		ps
Slew Rate Dispersion		$0.4 \text{ V/ns} \le \text{SR} \le 1.33 \text{ V/ns}$		50		ps
Pulse Width Dispersion		700 ps ≤ PW ≤ 10 ns		25		ps
Duty Cycle Dispersion		33 MHz, 1 V/ns, 0.5 V		15		ps
Common-Mode Voltage Dispersion		1 V swing, $-1.5 V \le V_{CM} \le +2.5 V$		10		ps

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
AC PERFORMANCE (continued)						
Equivalent Input Rise Time Bandwidth ¹	BW _{EQ}	0 V to 1 V swing, 2 V/ns		1500		MHz
Maximum Toggle Rate		>50% output swing		800		MHz
Minimum Pulse Width	PW _{MIN}	$\Delta t_{PD} < 25 \text{ ps}$		700		ps
RMS Random Jitter		V _{OD} = 400 mV, 1.3 V/ns, 312 MHz, 50% duty cycle		1.0		ps
Unit-to-Unit Propagation Delay Skew				100		ps
POWER SUPPLY						
Positive Supply Current	lvcc	@ +5.0 V	2	3.2	5	mA
Negative Supply Current	IVEE	@ -5.2 V	10	22	28	mA
Logic Supply Current	IVDD	@ 3.3 V without load	6	9	13	mA
Logic Supply Current		@ 3.3 V with load	45	60	70	mA
Positive Supply Voltage	Vcc	Dual	4.75	5.0	5.25	V
Negative Supply Voltage	VEE	Dual	-4.96	-5.2	-5.45	V
Logic Supply Voltage	V _{DD}	Dual	2.5	3.3	5.0	V
Power Dissipation	PD	Dual, without load	130	160	190	mW
Power Dissipation		Dual, with load	180	220	250	mW
DC Power Supply Rejection Ratio—V _{cc}	PSRRvcc			85		dB
DC Power Supply Rejection Ratio—V _{EE}	PSRR _{VEE}			85		dB
DC Power Supply Rejection Ratio—VDD	PSRRvdd			85		dB
HYSTERESIS (ADCMP562 Only)						
Hysteresis		$R_{HYS} = 19.5 \text{ k}\Omega$		20		mV
		$R_{HYS} = 8.0 \text{ k}\Omega$		70		mV

¹ Equivalent input rise time bandwidth assumes a first-order input response and is calculated by the following formula: $BW_{EQ} = 0.22/\sqrt{(tr_{COMP}^2 - tr_{IN}^2)}$, where tr_{IN} is the 20/80 input transition time applied to the comparator and tr_{COMP} is the effective transition time as digitized by the comparator input.

ABSOLUTE MAXIMUM RATINGS

Table 2.

Parameter	Rating					
Supply Voltages						
Positive Supply Voltage (V _{CC} to GND)	–0.5 V to +6.0 V					
Negative Supply Voltage (V_{EE} to GND)	–6.0 V to +0.5 V					
Logic Supply Voltage (V_{DD} to GND)	–0.5 V to +6.0 V					
Ground Voltage Differential	–0.5 V to +0.5 V					
Input Voltages						
Input Common-Mode Voltage	-3.0 V to +4.0 V					
Differential Input Voltage	–7.0 V to +7.0 V					
Input Voltage, Latch Controls	–0.5 V to +5.5 V					
Output						
Output Current	30 mA					
Temperature						
Operating Temperature, Ambient	-40°C to +85°C					
Operating Temperature, Junction	125°C					
Storage Temperature Range	–65°C to +150°C					

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

THERMAL CONSIDERATIONS

The ADCMP561 QSOP 16-lead package option has a θ_{JA} (junction-to-ambient thermal resistance) of 104°C/W in still air.

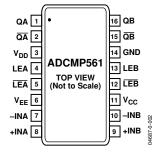
The ADCMP562 QSOP 20-lead package option has a θ_{JA} (junction-to-ambient thermal resistance) of 80°C/W in still air.

ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS



V _{DD} 1	•	20 V _{DD}	
QA 2		19 QB	
QA 3		18 QB	
V _{DD} 4	ADCMP562	17 GND	
LEA 5	TOP VIEW (Not to Scale)	16 LEB	
LEA 6	(,	15 LEB	
V _{EE} 7		14 V _{CC}	
–INA 8		13 –INB	
+INA 9		12 +INB	500
HYSA 10		11 HYSB	200-0-28900
)	2

Figure 4. ADCMP561 16-Lead QSOP Pin Configuration

Figure 5. ADCMP562 20-Lead QSOP Pin Configuration

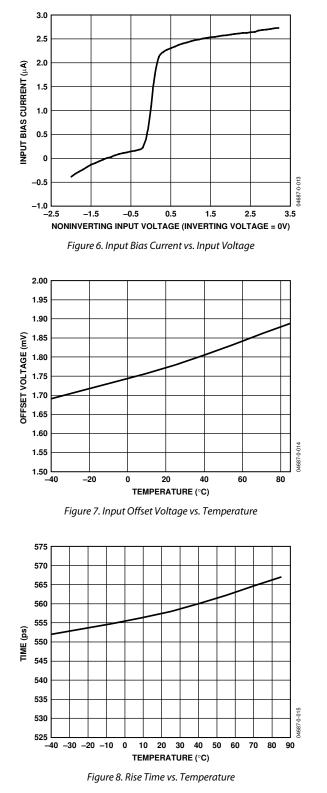
Table 3. Pin Function Descriptions

Pin No.						
ADCMP561	ADCMP562	Mnemonic	Function			
	1	V _{DD}	Logic Supply Terminal.			
1	2	QA	One of two complementary outputs for Channel A. QA is logic high if the analog voltage at the noninverting input is greater than the analog voltage at the inverting input (provided the comparator is in compare mode). See the description of Pin LEA for more information.			
2	3	QA	One of two complementary outputs for Channel A. \overline{QA} is logic low if the analog voltage at the noninverting input is greater than the analog voltage at the inverting input (provided the comparator is in compare mode). See the description of Pin LEA for more information.			
3	4	V _{DD}	Logic Supply Terminal.			
4	5	LEA	One of two complementary inputs for Channel A Latch Enable. In compare mode (logic high), the output tracks changes at the input of the comparator. In the latch mode (logic low), the output reflects the input state just prior to the comparator's being placed in the latch mode. LEA must be driven in conjunction with LEA. If left unconnected, the comparator defaults to compare mode. One of two complementary inputs for Channel A Latch Enable. In compare mode (logic low).			
5	6	LEA	One of two complementary inputs for Channel A Latch Enable. In compare mode (logic low), the output tracks changes at the input of the comparator. In latch mode (logic high), the output reflects the input state just prior to the comparator's being placed in the latch mode. LEA must be driven in conjunction with LEA. If left unconnected, the comparator defaults to compare mode.			
6	7	VEE	Negative Supply Terminal.			
7	8	–INA	Inverting Analog Input of the Differential Input Stage for Channel A. The inverting A input must be driven in conjunction with the noninverting A input.			
8	9	+INA	Noninverting Analog Input of the Differential Input Stage for Channel A. The noninverting A input must be driven in conjunction with the inverting A input.			
	10	HYSA	Programmable Hysteresis Input.			
	11	HYSB	Programmable Hysteresis Input.			
9	12	+INB	Noninverting Analog Input of the Differential Input Stage for Channel B. The noninverting B input must be driven in conjunction with the inverting B input.			
10	13	-INB	Inverting Analog Input of the Differential Input Stage for Channel B. The inverting B input must be driven in conjunction with the noninverting B input.			
11	14	Vcc	Positive Supply Terminal.			
12	15	LEB	One of two complementary inputs for Channel B Latch Enable. In compare mode (logic low), the output tracks changes at the input of the comparator. In latch mode (logic high), the output reflects the input state just prior to <u>placing</u> the comparator in the latch mode. LEB must be driven in conjunction with LEB. If left unconnected, the comparator defaults to compare mode.			

Pin No.				
ADCMP561	ADCMP562	Mnemonic	Function	
13	16	LEB	One of two complementary inputs for Channel B Latch Enable. In compare mode (logic high), the output tracks changes at the input of the comparator. In latch mode (logic low), the output reflects the input state just prior to placing the comparator in the latch mode. LEB must be driven in conjunction with LEP. If left unconnected, the comparator defaults to compare mode.	
			driven in conjunction with LEB. If left unconnected, the comparator defaults to compare mode.	
14	17	GND	Analog Ground.	
15	18	QB	One of two complementary outputs for Channel B. QB is logic low if the analog voltage at the noninverting input is greater than the analog voltage at the inverting input (provided the comparator is in compare mode). See the description of PIN LEB for more information.	
16	19	QB	One of two complementary outputs for Channel B. QB is logic high if the analog voltage at the noninverting input is greater than the analog voltage at the inverting input (provided the comparator is in compare mode). See the description of Pin LEB for more information.	
	20	V _{DD}	Logic Supply Terminal.	

TYPICAL PERFORMANCE CHARACTERISTICS

 V_{CC} = +5.0 V, V_{EE} = -5.2 V, V_{DD} = +3.3 V, T_{A} = 25°C, unless otherwise noted.



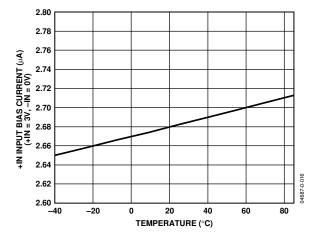
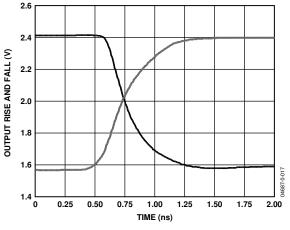


Figure 9. Input Bias Current vs. Temperature





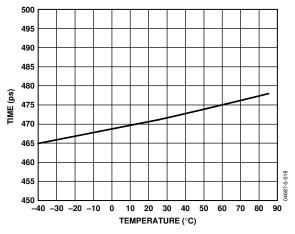


Figure 11. Fall Time vs. Temperature

Data Sheet

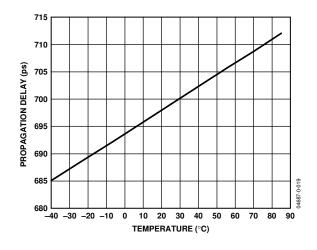
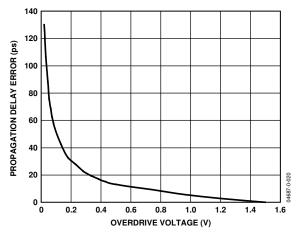


Figure 12. Propagation Delay vs. Temperature





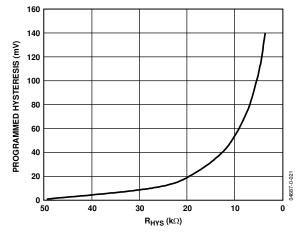


Figure 14. Comparator Hysteresis vs. R_{HYS}

ADCMP561/ADCMP562

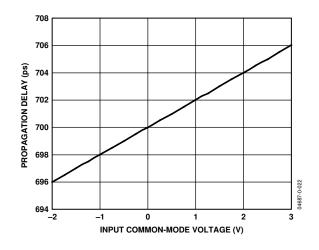


Figure 15. Propagation Delay vs. Common-Mode Voltage

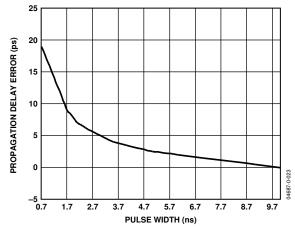


Figure 16. Propagation Delay Error vs. Pulse Width

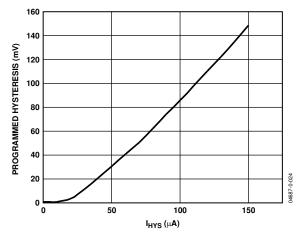


Figure 17. Comparator Hysteresis vs. I_{HYS}

TIMING INFORMATION

Figure 18 shows the compare and latch features of the ADCMP561/ADCMP562. Table 4 describes the terms in the diagram.

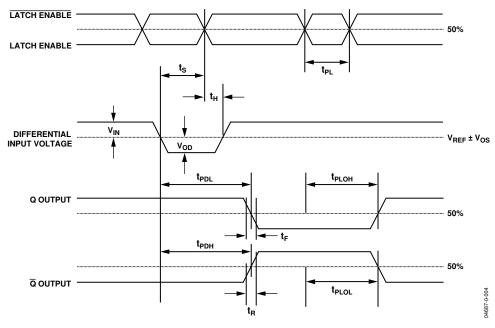


Figure 18. System Timing Diagram

Table 4. Timing Descriptions

Symbol	Timing	Description
t _{PDH}	Input to Output High Delay	Propagation delay measured from the time the input signal crosses the reference (± the input offset voltage) to the 50% point of an output low-to-high transition.
t PDL	Input to Output Low Delay	Propagation delay measured from the time the input signal crosses the reference (\pm the input offset voltage) to the 50% point of an output high-to-low transition.
t _{PLOH}	Latch Enable to Output High Delay	Propagation delay measured from the 50% point of the latch enable signal low-to-high transition to the 50% point of an output low-to-high transition.
t plol	Latch Enable to Output Low Delay	Propagation delay measured from the 50% point of the latch enable signal low-to-high transition to the 50% point of an output high-to-low transition.
tн	Minimum Hold Time	Minimum time after the negative transition of the latch enable signal that the input signal must remain unchanged to be acquired and held at the outputs.
t _{PL}	Minimum Latch Enable Pulse Width	Minimum time the latch enable signal must be high to acquire an input signal change.
ts	Minimum Setup Time	Minimum time before the negative transition of the latch enable signal that an input signal change must be present to be acquired and held at the outputs.
t _R	Output Rise Time	Amount of time required to transition from a low to a high output as measured at the 20% and 80% points.
t _F	Output Fall Time	Amount of time required to transition from a high to a low output as measured at the 20% and 80% points.
Vod	Voltage Overdrive	Difference between the differential input and reference input voltages.

APPLICATIONS INFORMATION

The ADCMP561/ADCMP562 comparators are very high speed devices. Consequently, high speed design techniques must be employed to achieve the best performance. The most critical aspect of any ADCMP561/ADCMP562 design is the use of a low impedance ground plane. A ground plane, as part of a multi-layer board, is recommended for proper high speed performance. Using a continuous conductive plane over the surface of the circuit board can create this, allowing breaks in the plane only for necessary signal paths. The ground plane provides a low inductance ground, eliminating any potential differences at different ground points throughout the circuit board caused by ground bounce. A proper ground plane also minimizes the effects of stray capacitance on the circuit board.

It is also important to provide bypass capacitors for the power supply in a high speed application. A 1 μ F electrolytic bypass capacitor should be placed within 0.5 inches of each power supply pin to ground. These capacitors reduce any potential voltage ripples from the power supply. In addition, a 10 nF ceramic capacitor should be placed as close as possible from the power supply pins on the ADCMP561/ADCMP562 to ground. These capacitors act as a charge reservoir for the device during high frequency switching.

The LATCH ENABLE input is active low (latched). If the latching function is not used, the LATCH ENABLE input may be left open or may be attached to V_{DD} (V_{DD} is a PECL logic high). The complementary input, LATCH ENABLE, may be left open or may be tied to V_{DD} – 2.0 V. Leaving the latch inputs unconnected or providing the proper voltages disables the latching function.

Occasionally, one of the two comparator stages within the ADCMP561/ADCMP562 is not used. The inputs of the unused comparator should not be allowed to float. The high internal gain may cause the output to oscillate (possibly affecting the comparator that is being used) unless the output is forced into a fixed state. This is easily accomplished by ensuring that the two inputs are at least one diode drop apart, while also appropriately connecting the LATCH ENABLE and LATCH ENABLE inputs as described previously.

The best performance is achieved with the use of proper PECL terminations. The open emitter outputs of the ADCMP561/ ADCMP562 are designed to be terminated through 50 Ω resistors to V_{DD} – 2.0 V, or any other equivalent PECL termination. If high speed PECL signals must be routed more than a centimeter, microstrip or stripline techniques may be required to ensure proper transition times and prevent output ringing.

CLOCK TIMING RECOVERY

Comparators are often used in digital systems to recover clock timing signals. High speed square waves transmitted over a distance, even tens of centimeters, can become distorted due to stray capacitance and inductance. Poor layout or improper termination can also cause reflections on the transmission line, further distorting the signal waveform. A high speed comparator can be used to recover the distorted waveform while maintaining a minimum of delay.

OPTIMIZING HIGH SPEED PERFORMANCE

As with any high speed comparator amplifier, proper design and layout techniques should be used to ensure optimal performance from the ADCMP561/ADCMP562. The performance limits of high speed circuitry can be a result of stray capacitance, improper ground impedance, or other layout issues.

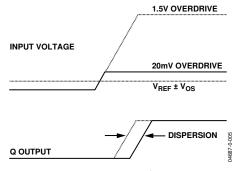
Minimizing resistance from source to the input is an important consideration in maximizing the high speed operation of the ADCMP561/ADCMP562. Source resistance in combination with equivalent input capacitance could cause a lagged response at the input, thus delaying the output. The input capacitance of the ADCMP561/ADCMP562, in combination with stray capacitance from an input pin to ground, could result in several picofarads of equivalent capacitance. A combination of 3 k Ω source resistance and 5 pF of input capacitance yields a time constant of 15 ns, which is significantly slower than the 750 ps capability of the ADCMP561/ADCMP562. Source impedances should be significantly less than 100 Ω for best performance.

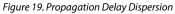
Sockets should be avoided due to stray capacitance and inductance. If proper high speed techniques are used, the devices should be free from oscillation when the comparator input signal passes through the switching threshold.

COMPARATOR PROPAGATION DELAY DISPERSION

The ADCMP561/ADCMP562 have been specifically designed to reduce propagation delay dispersion over an input overdrive range of 100 mV to 1.5 V. Propagation delay overdrive dispersion is the change in propagation delay that results from a change in the degree of overdrive (how far the switching point is exceeded by the input). The overall result is a higher degree of timing accuracy because the ADCMP561/ADCMP562 are far less sensitive to input variations than most comparator designs.

Propagation delay dispersion is a specification that is important in critical timing applications such as ATE, bench instruments, and nuclear instrumentation. Overdrive dispersion is defined as the variation in propagation delay as the input overdrive conditions are changed (Figure 19). For the ADCMP561 and ADCMP562, overdrive dispersion is typically 75 ps as the overdrive is changed from 100 mV to 1.5 V. This specification applies for both positive and negative overdrive because the ADCMP561/ADCMP562 have equal delays for positive and negative going inputs.



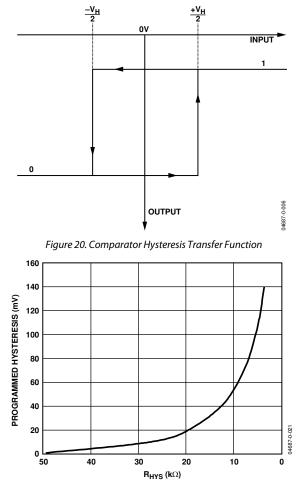


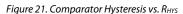
COMPARATOR HYSTERESIS

The addition of hysteresis to a comparator is often useful in a noisy environment, or where it is not desirable for the comparator to to toggle between states when the input signal is at the switching threshold. The transfer function for a comparator with hysteresis is shown in Figure 20. If the input voltage approaches the threshold from the negative direction, the comparator switches from a 0 to a 1 when the input crosses $+V_H/2$. The new switching threshold becomes $-V_H/2$. The comparator remains in a 1 state until the threshold $-V_H/2$ is crossed, coming from the positive direction. In this manner, noise centered on 0 V input does not cause the comparator to switch states unless it exceeds the region bounded by $\pm V_H/2$.

Positive feedback from the output to the input is often used to produce hysteresis in a comparator (Figure 24). The major problem with this approach is that the amount of hysteresis varies with the output logic levels, resulting in a hysteresis that is not symmetrical around zero.

In the ADCMP562, hysteresis is generated through the programmable hysteresis pin. A resistor from the HYS pin to GND creates a current into the part that is used to generate hysteresis. Hysteresis generated in this manner is independent of output swing and is symmetrical around the trip point. The hysteresis versus resistance curve is shown in Figure 21. A current source can also be used with the HYS pin. The relationship between the current applied to the HYS pin and the resulting hysteresis is shown in Figure 17.





MINIMUM INPUT SLEW RATE REQUIREMENT

As for all high speed comparators, a minimum slew rate must be met to ensure that the device does not oscillate when the input crosses the threshold. This oscillation is due in part to the high input bandwidth of the comparator and the parasitics of the package. Analog Devices recommends a slew rate of 1 V/µs or faster to ensure a clean output transition. If slew rates less than 1 V/µs are used, hysteresis should be added to reduce the oscillation.

TYPICAL APPLICATION CIRCUITS

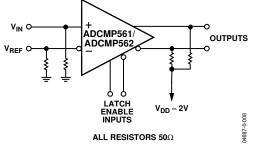


Figure 22. High Speed Sampling Circuits

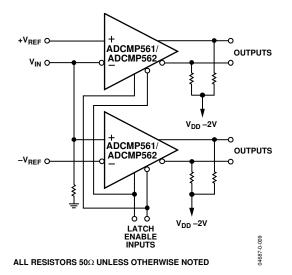


Figure 23. High Speed Window Comparator

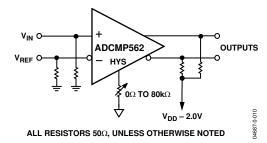


Figure 24. Adding Hysteresis Using the HYS Control Pin

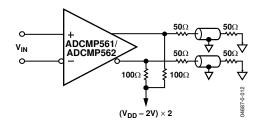
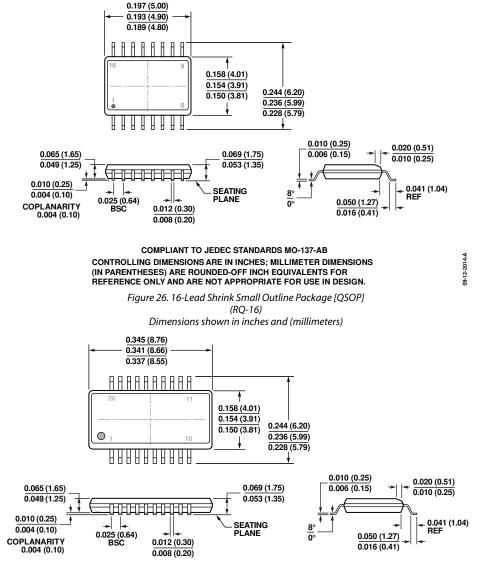


Figure 25. How to Interface a PECL Output to an Instrument with a 50 Ω to Ground Input

OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MO-137-AD CONTROLLING DIMENSIONS ARE IN INCHES; MILLIMETER DIMENSIONS (IN PARENTHESES) ARE ROUNDED-OFF INCH EQUIVALENTS FOR REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN.

> Figure 27. 20-Lead Shrink Small Outline Package [QSOP] (RQ-20)

Dimensions shown in inches and (millimeters)

ORDERING GUIDE

Model ¹	Temperature Range	Package Description	Package Option
ADCMP561BRQZ	-40°C to +85°C	16-Lead QSOP	RQ-16
ADCMP562BRQZ	-40°C to +85°C	20-Lead QSOP	RQ-20
ADCMP562BRQZ-RL7	–40°C to +85°C	20-Lead QSOP	RQ-20
EVAL-ADCMP561BRQZ		Evaluation Board	
EVAL-ADCMP562BRQZ		Evaluation Board	

¹ Z = RoHS Compliant Part.

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